LWR400G1207

SUSPM™

1200V 400A Chopper IGBT Module

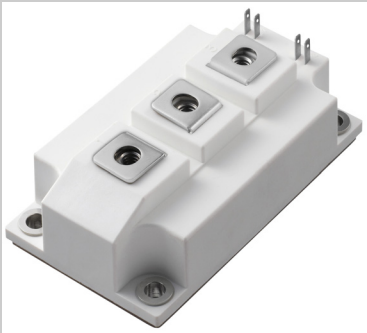
Features

- Trench & Field Stop technology (IGBT4)
  - Low Saturation Voltage
  - Low Turn-Off Losses
  - Short Tail Current
  - Positive Temperature Coefficient
  - High Ruggedness
- Free Wheeling Diodes with fast and soft reverse recovery
- Industrial Standard Package with copper base plate
- High Thermal Performance (AlN substrate is used)

Applications

- Boost (Power Supply)
- Brake Unit / UPS
- Battery Charger

Target data



SUSPM3

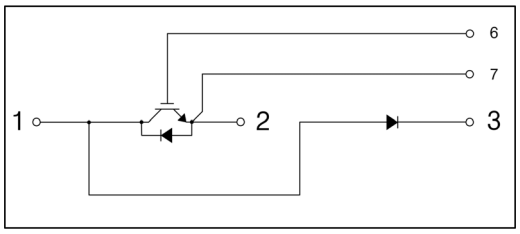
108 x 62 x 29.9 mm

Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Item	Symbol	Conditions	Value	Units
IGBT	V_{CES}		1200	V
	V_{GES}		± 20	V
	I_C	@T_j = 175 °C, T_C = 25 °C, Continuous	-	A
		@T_j = 175 °C, T_C = 80 °C, Continuous	400	A
	I_{CM}	@T_C = 80 °C, t_P = 1ms	800	A
	T_{SC}	Chip Level, @T_j = 150 °C, V_{GE} = 15 V, V_{CES} < 600 V	10	μs
	T_j	Operating Junction Temperature *(1)	-40~125	°C
	P_D	@T_j = 175°C, T_C = 25 °C	3500	W
		@T_j = 175 °C, T_C = 80 °C	2200	W
Reverse Diode	V_{RRM}		1200	V
	I_F		400	A
	I_{FRM}	t_P = 1 ms	800	A
	T_j	Operating Junction Temperature *(1)	-40~125	°C
Chopper Diode	V_{RRM}		1200	V
	I_F		400	A
	I_{FRM}	t_P = 1 ms	800	A
	T_j	Operating Junction Temperature *(2)	-40~125	°C
Module	T_{stg}	Storage Junction Temperature	-40~125	°C
	V_{iso}	@ AC 1 minute	2500	V
	M_t	Main Terminal Mounting torque (M6)	2.5~6.0	Nm
	M_S	Heat sink Mounting torque (M6)	3.0~6.0	Nm
	W	Weight	350	g

Internal Circuit & Pin Description

Pin Number	Pin Name	Pin Description
1	C	Positive DC Link
2	E	Negative DC Link
3	DC	Output
4		N.C
5		N.C
6	G	Gate Input for Low-side
7	E	Emitter Input for Low-side



(Note *1) The Maximum junction temperature of chip is 175 °C.
(Note *2) The Maximum junction temperature of chip is 150 °C.

Electrical Characteristics of IGBT T_C = 25°C unless otherwise noted

Static Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
BV_{CES}	C-E Breakdown Voltage	V_{GE} = 0 V, I_C = 1 mA	1200	-	-	V
I_{CES}	C-E Cut-Off Current	V_{CE} = V_{CES}, V_{GE} = 0 V	-	-	1	mA
I_{GES}	G-E Leakage Current	V_{GE} = V_{GES}, V_{CE} = 0 V	-	-	-	nA
$V_{GE(th)}$	G-E Threshold Voltage	V_{GE} = V_{CE}, I_C = 400 mA	-	6.3	-	V
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	I_C = 400 A, V_{GE} = 15 V, T_C = 25 °C	-	2.25	-	V
		I_C = 400 A, V_{GE} = 15 V, T_C = 125 °C	-	2.80	-	V

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
C_{ies}	Input Capacitance	V_{CE} = 25 V, V_{GE} = 0 V f = 1 MHz, T_C = 25 °C	-	27.2	-	nF
C_{oes}	Output Capacitance		-	1.8	-	nF
C_{res}	Reverse Transfer Capacitance		-	1.5	-	nF
t_d(on)	Turn-On Delay Time	T_C = 125 °C, R_G = 1.8 Ω L = 25 μH, V_{DC} = 600 V V_{GE} = 15 V ~ -15 V I_C = 400 A	-	-	-	ns
t_r	Rise Time		-	-	-	ns
t_d(off)	Turn-Off Delay Time		-	-	-	ns
t_f	Fall Time		-	-	-	ns
E_{on}	Turn-On Switching Loss		-	-	-	mJ
E_{off}	Turn-Off Switching Loss		-	-	-	mJ
E_{ts}	Total Switching Loss		-	-	-	mJ
Q_g	Total Gate Charge	V_{GE} = 0 V ~ +15 V	-	1.95	-	μC
Q_{ge}	Gate-Emitter Charge		-	0.24	-	μC
Q_{gc}	Gate-Collector Charge		-	1.11	-	μC

Electrical Characteristics of Reverse Diode

Symbol	Parameter	Test Conditions		Min	Typ	Max	Units
V_F	Diode Forward Voltage	I_F = 400 A	T_C = 125 °C	-	3.0	-	V
t_{rr}	Diode Reverse Recovery Time	R_G = 1.8 Ω L = 25 μH V_{DC} = 600 V V_{GE} = 15 V ~ -15 V I_C = 400 A	T_C = 125 °C	-	-	-	
I_{RRM}	Diode Peak Reverse Recovery Current		T_C = 125 °C	-	-	-	
Q_{rr}	Diode Reverse Recovery Charge		T_C = 125 °C	-	-	-	
E_{rr}	Diode Reverse Recovery Energy		T_C = 125 °C	-	-	-	

Electrical Characteristics of Chopper Diode

Symbol	Parameter	Test Conditions		Min	Typ	Max	Units
V_F	Diode Forward Voltage	I_F = 400 A	T_C = 125 °C	-	2.9	-	V
t_{rr}	Diode Reverse Recovery Time	R_G = 1.8 Ω L = 25 μH V_{DC} = 600 V V_{GE} = 15 V ~ -15 V I_F = 400 A	T_C = 125 °C	-	-	-	
I_{RRM}	Diode Peak Reverse Recovery Current		T_C = 125 °C	-	-	-	
Q_{rr}	Diode Reverse Recovery Charge		T_C = 125 °C	-	-	-	
E_{rr}	Diode Reverse Recovery Energy		T_C = 125 °C	-	-	-	

Thermal Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
$R_{th(J-C)}$	Thermal Resistance (IGBT)	Junction-to-Case	-	0.042	-	°C/W
$R_{th(J-C)}$	Thermal Resistance (Reverse Diode)	Junction-to-Case	-	-	-	°C/W
$R_{th(J-C)}$	Thermal Resistance (Chopper Diode)	Junction-to-Case	-	-	-	°C/W

* This specifications may not be considered as an assurance of characteristics and may not have same characteristics in case of using different test systems from @ LSIS. We therefore strongly recommend prior consultation of our engineers.

Package Dimension (Dimension in mm)